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FEATURES

- Guaranteed monotonic
- INL error: ± 4 LSB max
- On-chip 1.25 V/2.5 V, 10 ppm/ $^{\circ}$ C reference
- Temperature range: -40° C to $+85^{\circ}$ C
- Rail-to-rail output amplifier
- Power down
- Package type: 100-lead LQFP (14 mm \times 14 mm)
- User interfaces
 - Parallel
 - Serial (SPI[®]-, QSPI[™]-, MICROWIRE[™]-, DSP-compatible, featuring data readback)
 - I²C[®]-compatible
- Robust 6.5 kV HBM and 2 kV FICDM ESD rating

INTEGRATED FUNCTIONS

- Channel monitor
- Simultaneous output update via $\overline{\text{LDAC}}$
- Clear function to user programmable code
- Amplifier boost mode to optimize slew rate
- User programmable offset and gain adjust
- Toggle mode enables square wave generation
- Thermal monitor

APPLICATIONS

- Variable optical attenuators (VOA)
- Level setting (ATE)
- Optical micro-electro-mechanical systems (MEMS)
- Control systems
- Instrumentation

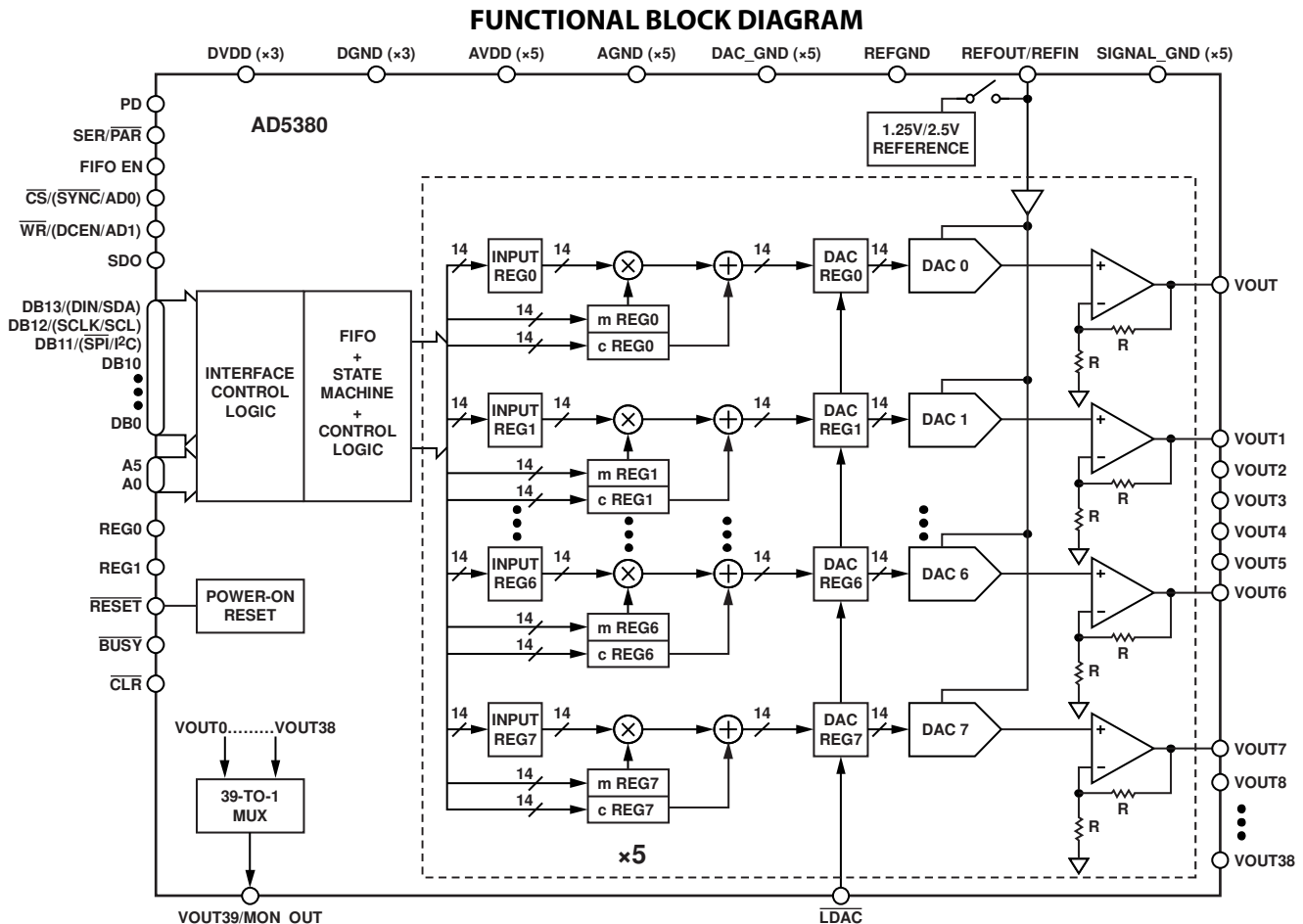


Figure 1.

Rev. D

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COMPARABLE PARTS

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EVALUATION KITS

- AD5380 Evaluation Board

DOCUMENTATION

Application Notes

- AN-1222: 40 Channels of Programmable Voltage with Excellent Temperature Drift Performance Using the AD5380 DAC
- AN-1223: Output Channel Monitoring Using the AD5380 Multichannel DAC

Data Sheet

- AD5380:40-Channel, 3 V/5 V, Single-Supply, 14-Bit, denseDAC Data Sheet

Product Highlight

- Extending the *denseDAC*™ Multichannel D/As

User Guides

- UG-757: Evaluating the AD5380/AD5382 40-/32-Channel, 14-Bit Voltage Output DACs with On-Chip Reference

SOFTWARE AND SYSTEMS REQUIREMENTS

- AD5380 IIO Multi-Channel DAC Linux Driver

REFERENCE MATERIALS

Solutions Bulletins & Brochures

- Digital to Analog Converters ICs Solutions Bulletin

Technical Articles

- Software Calibration Reduces D/A Converter Offset and Gain Errors

DESIGN RESOURCES

- AD5380 Material Declaration
- PCN-PDN Information
- Quality And Reliability
- Symbols and Footprints

DISCUSSIONS

View all AD5380 EngineerZone Discussions.

SAMPLE AND BUY

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REVISION HISTORY**5/14—Rev. C to Rev. D**

Deleted ADSP-2103	Throughout
Changed ADSP-2101 to ADSP-BF527	Throughout
Deleted Table 1; Renumbered Sequentially	3
Changes to General Description Section	4
Changed Logic Inputs (Except SDA/SCL), Input Current Parameter, Table 1 from $\pm 10 \mu\text{A}$ max to $\pm 1 \mu\text{A}$ max	5
Changed Logic Inputs (Except SDA/SCL), Input Current Parameter, Table 2 from $\pm 10 \mu\text{A}$ max to $\pm 1 \mu\text{A}$ max	7
Changes to Table 4	9
Changes to Table 6	12
Changes to Soft Reset Section	23
Changes to Reset Function Section	26
Changes to Figure 38	33
Added Power Supply Sequencing Section, Table 18, Figure 39, and Figure 40; Renumbered Sequentially	34
Changed ADR280 to ADR3412, Typical Configuration Circuit Section	35
Added Figure 41 and Figure 42	35

9/12—Rev. B to Rev. C

Changes to Product Title	1
Changes to General Description Section and Table 1	3
Deleted Table 2; Renumbered Sequentially	3

6/12—Rev. A to Rev. B

Changes to Features	1
Changes to Table 3	4
Changes to Table 4	6
Changes to Output Voltage Settling Time and Slew Rate Parameters, Table 5	7
Changes to t_{14} and t_{19} Parameters, Table 6	8
Changes to Table 9	13
Changes to Figure 10, Figure 11, and Figure 14	18
Changes to Figure 16, Figure 17, Figure 18, Figure 20	19
Update Outline Dimensions and Changes to Ordering Guide	38

6/05—Rev. 0 to Rev. A

Changes to Specifications	3
Changes to Terminology	17
Changes to Table 18	24
Changes to Figure 43	35

5/04—Revision 0: Initial Version

GENERAL DESCRIPTION

The AD5380 is a complete, single-supply, 40-channel, 14-bit *denseDAC*® available in a 100-lead LQFP package. All 40 channels have an on-chip output amplifier with rail-to-rail operation. The AD5380 includes a programmable internal 1.25 V/2.5 V, 10 ppm/°C reference, an on-chip channel monitor function that multiplexes the analog outputs to a common MON_OUT pin for external monitoring, and an output amplifier boost mode that allows optimization of the amplifier slew rate. The AD5380 contains a double-buffered parallel interface that features a 20 ns \overline{WR} pulse width, an SPI-, QSPI-, -MICROWIRE, -DSP compatible serial interface with interface speeds in excess of 30 MHz, and an I²C-compatible interface that supports a 400 kHz data transfer rate.

An input register followed by a DAC register provides double buffering, allowing the DAC outputs to be updated independently or simultaneously using the \overline{LDAC} input.

Each channel has a programmable gain and offset adjust register that allows the user to fully calibrate any DAC channel. Power consumption is typically 0.25 mA/channel with boost off.

SPECIFICATIONS

AD5380-5 SPECIFICATIONS

AVDD = 4.5 V to 5.5 V; DVDD = 2.7 V to 5.5 V, AGND = DGND = 0 V; External REFIN = 2.5 V; all specifications T_{MIN} to T_{MAX}, unless otherwise noted.

Table 1.

Parameter	AD5380-5 ¹	Unit	Test Conditions/Comments
ACCURACY			
Resolution	14	Bits	
Relative Accuracy (INL) ²	±4	LSB max	±1 LSB typical
Differential Nonlinearity (DNL)	-1/+2	LSB max	Guaranteed monotonic by design over temperature
Zero-Scale Error	4	mV max	
Offset Error	±4	mV max	Measured at code 32 in the linear region
Offset Error TC	±5	µV/°C typ	
Gain Error	±0.05	% FSR max	At 25°C
	±0.06	% FSR max	T _{MIN} to T _{MAX}
Gain Temperature Coefficient ³	2	ppm FSR/°C typ	
DC Crosstalk ³	1	LSB max	
REFERENCE INPUT/OUTPUT			
Reference Input ³			
Reference Input Voltage	2.5	V	±1% for specified performance, AVDD = 2 × REFIN + 50 mV
DC Input Impedance	1	MΩ min	Typically 100 MΩ
Input Current	±1	µA max	Typically ±30 nA
Reference Range	1 to V _{DD} /2	V min/max	
Reference Output ⁴			
Output Voltage	2.495/2.505	V min/max	Enabled via CR10 in the AD5380 control register; CR12 selects the reference voltage
	1.22/1.28	V min/max	At ambient, CR12 = 1, optimized for 2.5 V operation
Reference TC ³	±10	ppm max	CR12 = 0
	±15	ppm max	Temperature range: +25°C to +85°C
Output Impedance	800	Ω typ	Temperature range: -40°C to +85°C
OUTPUT CHARACTERISTICS³			
Output Voltage Range ²	0/AVDD	V min/max	
Short-Circuit Current	40	mA max	
Load Current	±1	mA max	
Capacitive Load Stability			
R _L = ∞	200	pF max	
R _L = 5 kΩ	1000	pF max	
DC Output Impedance	0.6	Ω max	
MONITOR PIN			
Output Impedance	1	kΩ typ	
Three-State Leakage Current	100	nA typ	
LOGIC INPUTS (EXCEPT SDA/SCL)³			
V _{IH} , Input High Voltage	2	V min	DVDD = 2.7 V to 5.5 V
V _{IL} , Input Low Voltage			
DVDD > 3.6 V	0.8	V max	
DVDD ≤ 3.6 V	0.6	V max	
Input Current	±1	µA max	
Pin Capacitance	10	pF max	Total for all pins; T _A = T _{MIN} to T _{MAX}

Parameter	AD5380-5 ¹	Unit	Test Conditions/Comments
LOGIC INPUTS (SDA, SCL ONLY)³			
V _{IH} , Input High Voltage	0.7 × DVDD	V min	SMBus compatible at DVDD < 3.6 V
V _{IL} , Input Low Voltage	0.3 × DVDD	V max	SMBus compatible at DVDD < 3.6 V
I _{IN} , Input Leakage Current	±1	µA max	
V _{HYST} , Input Hysteresis	0.05 × DVDD	V min	
C _{IN} , Input Capacitance	8	pF typ	
Glitch Rejection	50	ns max	Input filtering suppresses noise spikes of less than 50 ns
LOGIC OUTPUTS (BUSY, SDO)³			
V _{OL} , Output Low Voltage	0.4	V max	DVDD = 5 V ± 10%, sinking 200 µA
V _{OH} , Output High Voltage	DVDD – 1	V min	DVDD = 5 V ± 10%, sourcing 200 µA
V _{OL} , Output Low Voltage	0.4	V max	DVDD = 2.7 V to 3.6 V, sinking 200 µA
V _{OH} , Output High Voltage	DVDD – 0.5	V min	DVDD = 2.7 V to 3.6 V, sourcing 200 µA
High Impedance Leakage Current	±1	µA max	SDO only
High Impedance Output Capacitance	5	pF typ	SDO only
LOGIC OUTPUT (SDA)³			
V _{OL} , Output Low Voltage	0.4	V max	I _{SINK} = 3 mA
	0.6	V max	I _{SINK} = 6 mA
Three-State Leakage Current	±1	µA max	
Three-State Output Capacitance	8	pF typ	
POWER REQUIREMENTS			
AVDD	4.5/5.5	V min/max	
DVDD	2.7/5.5	V min/max	
Power Supply Sensitivity ³ ΔMidscale/ΔAVDD	–85	dB typ	
A _{DD}	0.375	mA/channel max	Outputs unloaded; boost off; 0.25 mA/channel typ
	0.475	mA/channel max	Outputs unloaded; boost on; 0.325 mA/channel typ
D _{DD}	1	mA max	V _{IH} = DVDD, V _{IL} = DGND
A _{DD} (Power-Down)	20	µA max	Typically 100 nA
D _{DD} (Power-Down)	20	µA max	Typically 1 µA
Power Dissipation	80	mW max	Outputs unloaded, boost off, AVDD = DVDD = 5 V

¹ AD5380-5 is calibrated using an external 2.5 V reference. Temperature range for all versions: –40°C to +85°C.

² Accuracy guaranteed from V_{OUT} = 10 mV to AVDD – 50 mV.

³ Guaranteed by characterization, not production tested.

⁴ Default on the AD5380-5 is 2.5 V. Programmable to 1.25 V via CR12 in the AD5380 control register; operating the AD5380-5 with a 1.25 V reference will lead to degraded accuracy specifications.

AD5380-3 SPECIFICATIONS

AVDD = 2.7 V to 3.6 V; DVDD = 2.7 V to 5.5 V, AGND = DGND = 0 V; external REFIN = 1.25 V; all specifications T_{MIN} to T_{MAX}, unless otherwise noted.

Table 2.

Parameter	AD5380-3 ¹	Unit	Test Conditions/Comments
ACCURACY			
Resolution	14	Bits	
Relative Accuracy (INL) ²	±4	LSB max	
Differential Nonlinearity (DNL)	-1/+2	LSB max	Guaranteed monotonic over temperature
Zero-Scale Error	4	mV max	
Offset Error	±4	mV max	Measured at Code 64 in the linear region
Offset Error TC	±5	μV/°C typ	
Gain Error	±0.05	% FSR max	At 25°C
	±0.1	% FSR max	T _{MIN} to T _{MAX}
Gain Temperature Coefficient ³	2	ppm FSR/°C typ	
DC Crosstalk ³	1	LSB max	
REFERENCE INPUT/OUTPUT			
Reference Input ³			
Reference Input Voltage	1.25	V	±1% for specified performance
DC Input Impedance	1	MΩ min	Typically 100 MΩ
Input Current	±1	μA max	Typically ±30 nA
Reference Range	1 to AVDD/2	V min/max	
Reference Output ⁴			Enabled via CR10 in the AD5380 control register; CR12 selects the reference voltage
Output Voltage	1.245/1.255	V min/max	At ambient; CR12 = 0; Optimized for 1.25 V operation
	2.47/2.53	V min/max	CR12 = 1.
Reference TC ³	±10	ppm/°C max	Temperature range: +25°C to +85°C
	±15	ppm/°C max	Temperature range: -40°C to +85°C
Output Impedance	800	Ω typ	
OUTPUT CHARACTERISTICS ³			
Output Voltage Range ²	0/AVDD	V min/max	
Short-Circuit Current	40	mA max	
Load Current	±1	mA max	
Capacitive Load Stability			
R _L = ∞	200	pF max	
R _L = 5 kΩ	1000	pF max	
DC Output Impedance	0.6	Ω max	
MONITOR PIN			
Output Impedance	1	kΩ typ	
Three-State Leakage Current	100	nA typ	
LOGIC INPUTS (EXCEPT SDA/SCL) ³			DVDD = 2.7 V to 3.6 V
V _{IH} , Input High Voltage	2	V min	
V _{IL} , Input Low Voltage			
DVDD > 3.6 V	0.8	V max	
DVDD ≤ 3.6 V	0.6	V max	
Input Current	±1	μA max	Total for all pins; T _A = T _{MIN} to T _{MAX}
Pin Capacitance	10	pF max	
LOGIC INPUTS (SDA, SCL ONLY) ³			
V _{IH} , Input High Voltage	0.7 × DVDD	V min	SMBus-compatible at DVDD < 3.6 V
V _{IL} , Input Low Voltage	0.3 × DVDD	V max	SMBus-compatible at DVDD < 3.6 V
I _{IN} , Input Leakage Current	±1	μA max	
V _{HYST} , Input Hysteresis	0.05 × DVDD	V min	
C _{IN} , Input Capacitance	8	pF typ	
Glitch Rejection	50	ns max	Input filtering suppresses noise spikes of less than 50 ns

Parameter	AD5380-3 ¹	Unit	Test Conditions/Comments
LOGIC OUTPUTS ($\overline{\text{BUSY}}$, SDO) ³			
V_{OL} , Output Low Voltage	0.4	V max	Sinking 200 μA
V_{OH} , Output High Voltage	DVDD – 0.5	V min	Sourcing 200 μA
High Impedance Leakage Current	± 1	μA max	SDO only
High Impedance Output Capacitance	5	pF typ	SDO only
LOGIC OUTPUT (SDA) ³			
V_{OL} , Output Low Voltage	0.4	V max	$I_{\text{SINK}} = 3 \text{ mA}$
	0.6	V max	$I_{\text{SINK}} = 6 \text{ mA}$
Three-State Leakage Current	± 1	μA max	
Three-State Output Capacitance	8	pF typ	
POWER REQUIREMENTS			
AVDD	2.7/3.6	V min/max	
DVDD	2.7/5.5	V min/max	
Power Supply Sensitivity ³ $\Delta\text{Midscale}/\Delta\text{AVDD}$	-85	dB typ	
A_{DD}	0.375	mA/channel max	Outputs unloaded; boost off; 0.25 mA/channel typical
	0.475	mA/channel max	Outputs unloaded; boost on; 0.325 mA/channel typical
D_{DD}	1	mA max	$V_{\text{IH}} = \text{DVDD}$, $V_{\text{IL}} = \text{DGND}$
A_{DD} (Power-Down)	20	μA max	Typically 100 nA
D_{DD} (Power-Down)	20	μA max	Typically 1 μA
Power Dissipation	48	mW max	Outputs unloaded; boost off, AVDD = DVDD = 3 V

¹ AD5380-3 is calibrated using an external 1.25 V reference. Temperature range is -40°C to $+85^{\circ}\text{C}$.

² Accuracy guaranteed from $V_{\text{OUT}} = 10 \text{ mV}$ to $\text{AVDD} - 50 \text{ mV}$.

³ Guaranteed by characterization, not production tested.

⁴ Default on the AD5380-3 is 1.25 V. Programmable to 2.5 V via CR12 in the AD5380 control register; operating the AD5380-3 with a 2.5 V reference will lead to degraded accuracy specifications and limited input code range.

AC CHARACTERISTICS¹

AVDD = 2.7 V to 3.6 V or 4.5 V to 5.5 V; DVDD = 2.7 V to 5.5 V; AGND = DGND = 0 V.

Table 3.

Parameter	All	Unit	Test Conditions/Comments
DYNAMIC PERFORMANCE			
Output Voltage Settling Time ²			1/4 scale to 3/4 scale change settling to $\pm 1 \text{ LSB}$
	3	μs typ	Boost mode off, CR11 = 0
	8	μs max	Boost mode off, CR11 = 0
Slew Rate ²			Boost mode off, CR11 = 0
	1.5	V/ μs typ	Boost mode off, CR11 = 0
	2.5	V/ μs typ	Boost mode on, CR11 = 1
Digital-to-Analog Glitch Energy	12	nV-s typ	
Glitch Impulse Peak Amplitude	15	mV typ	
DAC-to-DAC Crosstalk	1	nV-s typ	See Terminology section
Digital Crosstalk	0.8	nV-s typ	
Digital Feedthrough	0.1	nV-s typ	Effect of input bus activity on DAC output under test
Output Noise 0.1 Hz to 10 Hz	15	μV p-p typ	External reference, midscale loaded to DAC
	40	μV p-p typ	Internal reference, midscale loaded to DAC
Output Noise Spectral Density			
At 1 kHz	150	nV/ $\sqrt{\text{Hz}}$ typ	
At 10 kHz	100	nV/ $\sqrt{\text{Hz}}$ typ	

¹ Guaranteed by design and characterization, not production tested.

² The slew rate can be programmed via the current boost control bit (CR11) in the AD5380 control register.

TIMING CHARACTERISTICS

SERIAL INTERFACE

DVDD = 2.7 V to 5.5 V; AVDD = 4.5 V to 5.5 V or 2.7 V to 3.6 V; AGND = DGND = 0 V; all specifications T_{MIN} to T_{MAX} , unless otherwise noted.

Table 4.

Parameter ^{1, 2, 3}	Limit at T_{MIN} , T_{MAX}	Unit	Description
t_1	33	ns min	SCLK cycle time
t_2	13	ns min	SCLK high time
t_3	13	ns min	SCLK low time
t_4	13	ns min	\overline{SYNC} falling edge to SCLK falling edge setup time
t_5^4	13	ns min	24 th SCLK falling edge to \overline{SYNC} falling edge
t_6^4	33	ns min	Minimum \overline{SYNC} low time
t_7	10	ns min	Minimum \overline{SYNC} high time
t_{7A}	140	ns min	Minimum \overline{SYNC} high time in readback mode
t_8	5	ns min	Data setup time
t_9	4.5	ns min	Data hold time
t_{10}^4	36	ns max	24th SCLK falling edge to \overline{BUSY} falling edge
t_{11}	670	ns max	\overline{BUSY} pulse width low (single channel update)
t_{12}^4	20	ns min	24th SCLK falling edge to \overline{LDAC} falling edge
t_{13}	20	ns min	\overline{LDAC} pulse width low
t_{14}	100/2000	ns min/max	\overline{BUSY} rising edge to DAC output response time
t_{15}	0	ns min	\overline{BUSY} rising edge to \overline{LDAC} falling edge
t_{16}	100/2000	ns min/max	\overline{LDAC} falling edge to DAC output response time
t_{17}	3	μ s typ	DAC output settling time; boost mode off
t_{18}	20	ns min	\overline{CLR} pulse width low
t_{19}	40	μ s max	\overline{CLR} pulse activation time
t_{20}^5	30	ns max	SCLK rising edge to SDO valid
t_{21}^5	5	ns min	SCLK falling edge to \overline{SYNC} rising edge
t_{22}^5	8	ns min	\overline{SYNC} rising edge to SCLK rising edge
t_{23}	20	ns min	\overline{SYNC} rising edge to \overline{LDAC} falling edge

¹ Guaranteed by design and characterization, not production tested.

² All input signals are specified with $t_r = t_f = 5$ ns (10% to 90% of VCC), and are timed from a voltage level of 1.2 V.

³ See Figure 2, Figure 3, Figure 4, and Figure 5.

⁴ Standalone mode only.

⁵ Daisy-chain mode only.

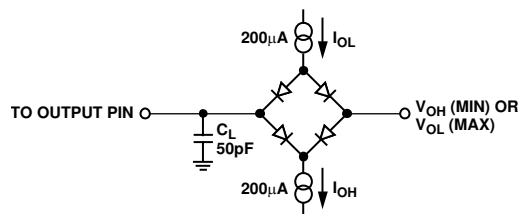
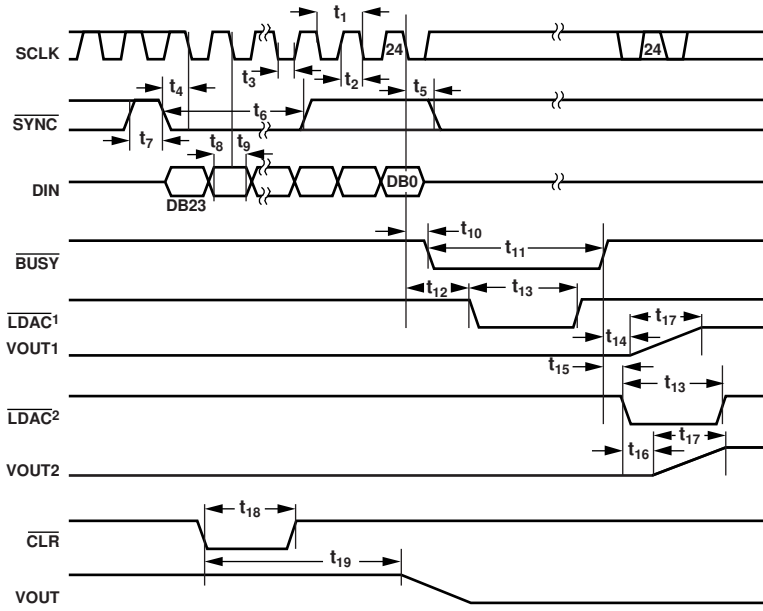


Figure 2. Load Circuit for Digital Output Timing

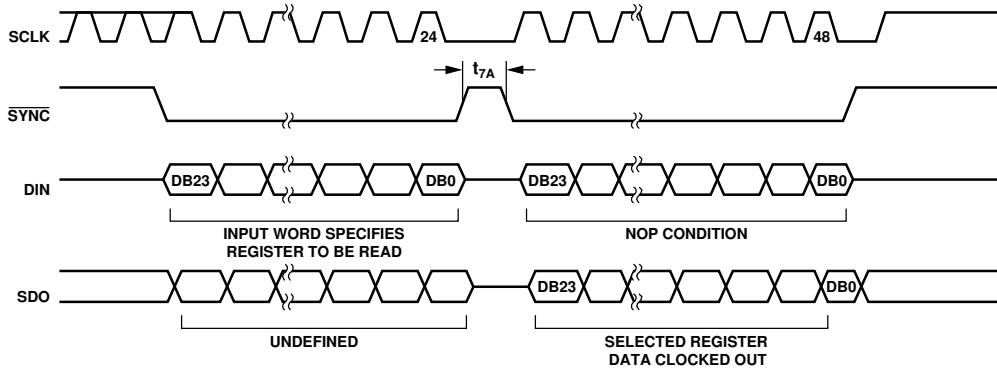
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¹LDAC ACTIVE DURING BUSY.
²LDAC ACTIVE AFTER BUSY.

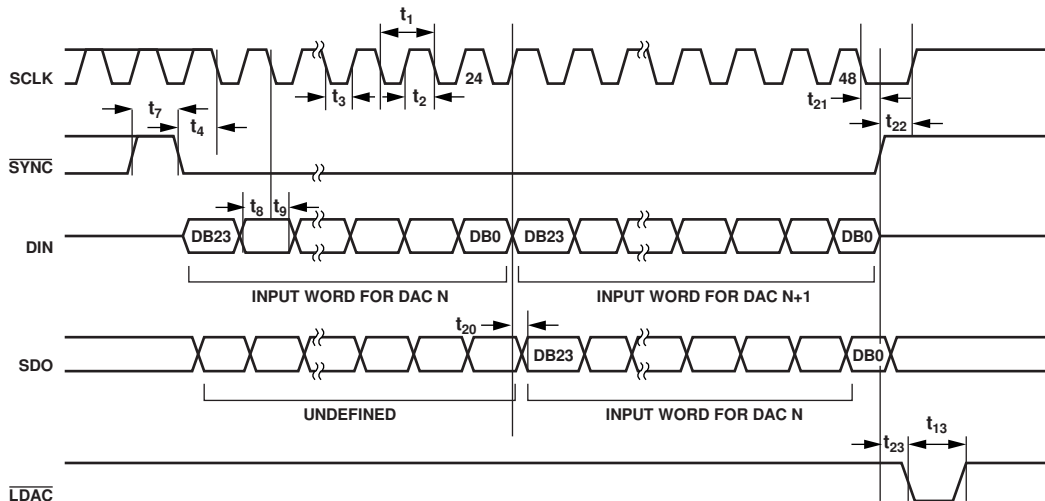
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Figure 3. Serial Interface Timing Diagram (Standalone Mode)



03731-004

Figure 4. Serial Interface Timing Diagram (Data Readback Mode)



03731-005

Figure 5. Serial Interface Timing Diagram (Daisy-Chain Mode)

I²C SERIAL INTERFACE

DVDD = 2.7 V to 5.5 V; AVDD = 4.5 V to 5.5 V or 2.7 V to 3.6 V; AGND = DGND = 0 V; all specifications T_{MIN} to T_{MAX}, unless otherwise noted.

Table 5.

Parameter ^{1,2}	Limit at T _{MIN} , T _{MAX}	Unit	Description
f _{SCL}	400	kHz max	SCL clock frequency
t ₁	2.5	μs min	SCL cycle time
t ₂	0.6	μs min	t _{HIGH} , SCL high time
t ₃	1.3	μs min	t _{LOW} , SCL low time
t ₄	0.6	μs min	t _{HD,STA} , start/repeated start condition hold time
t ₅	100	ns min	t _{SU,DAT} , data setup time
t ₆ ³	0.9	μs max	t _{HD,DAT} , data hold time
	0	μs min	t _{HD,DAT} , data hold time
t ₇	0.6	μs min	t _{SU,STA} , setup time for repeated start
t ₈	0.6	μs min	t _{SU,STO} , stop condition setup time
t ₉	1.3	μs min	t _{BUF} , bus free time between a STOP and a START condition
t ₁₀	300	ns max	t _R , rise time of SCL and SDA when receiving
	0	ns min	t _R , rise time of SCL and SDA when receiving (CMOS compatible)
t ₁₁	300	ns max	t _F , fall time of SDA when transmitting
	0	ns min	t _F , fall time of SDA when receiving (CMOS compatible)
	300	ns max	t _F , fall time of SCL and SDA when receiving
	20 + 0.1C _b ⁴	ns min	t _F , fall time of SCL and SDA when transmitting
C _b	400	pF max	Capacitive load for each bus line

¹ Guaranteed by design and characterization, not production tested.

² See Figure 6.

³ A master device must provide a hold time of at least 300 ns for the SDA signal (referred to the VIH min of the SCL signal) in order to bridge the undefined region of SCL's falling edge.

⁴ C_b is the total capacitance, in pF, of one bus line. t_R and t_F are measured between 0.3 DVDD and 0.7 DVDD.

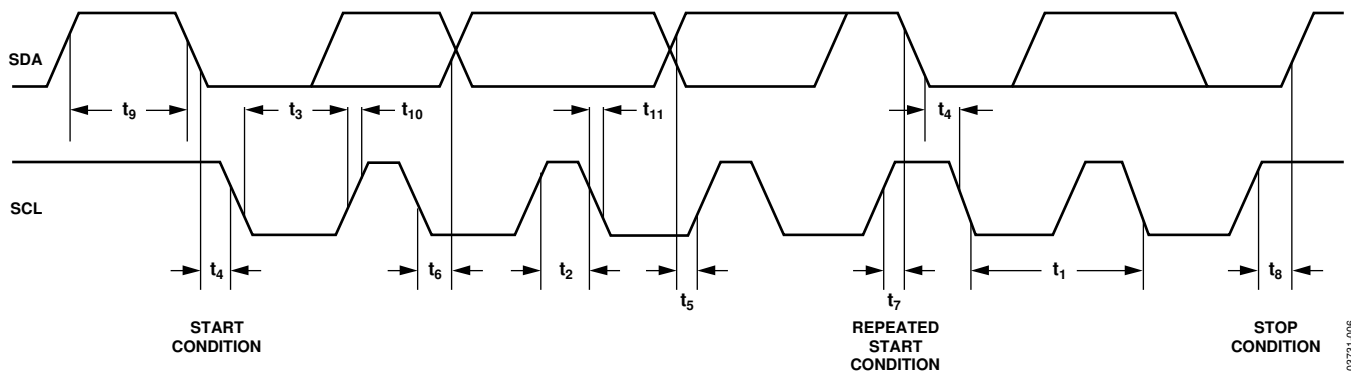


Figure 6. I²C Compatible Serial Interface Timing Diagram

03731-006

PARALLEL INTERFACE

DVDD = 2.7 V to 5.5 V; AVDD = 4.5 V to 5.5 V or 2.7 V to 3.6 V; AGND = DGND = 0 V; all specifications T_{MIN} to T_{MAX}, unless otherwise noted.

Table 6.

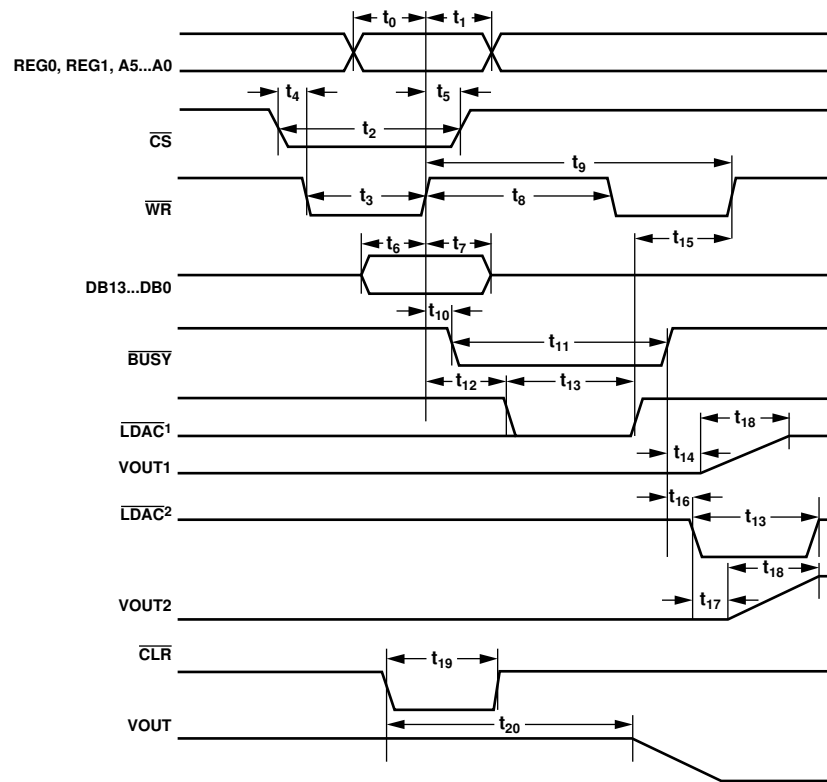
Parameter ^{1, 2, 3}	Limit at T _{MIN} , T _{MAX}	Unit	Description
t ₀	4.5	ns min	REG0, REG1, address to \overline{WR} rising edge setup time
t ₁	4.5	ns min	REG0, REG1, address to \overline{WR} rising edge hold time
t ₂	20	ns min	\overline{CS} pulse width low
t ₃	20	ns min	\overline{WR} pulse width low
t ₄	0	ns min	\overline{CS} to \overline{WR} falling edge setup time
t ₅	0	ns min	\overline{WR} to \overline{CS} rising edge hold time
t ₆	4.5	ns min	Data to \overline{WR} rising edge setup time
t ₇	4.5	ns min	Data to \overline{WR} rising edge hold time
t ₈	20	ns min	\overline{WR} pulse width high
t ₉ ⁴	700	ns min	Minimum \overline{WR} cycle time (single-channel write)
t ₁₀	30	ns max	\overline{WR} rising edge to \overline{BUSY} falling edge
t ₁₁ ⁴	670	ns max	\overline{BUSY} pulse width low (single-channel update)
t ₁₂	30	ns min	\overline{WR} rising edge to \overline{LDAC} falling edge
t ₁₃	20	ns min	\overline{LDAC} pulse width low
t ₁₄	100/2000	ns min/max	\overline{BUSY} rising edge to DAC output response time
t ₁₅	20	ns min	\overline{LDAC} rising edge to \overline{WR} rising edge
t ₁₆	0	ns min	\overline{BUSY} rising edge to \overline{LDAC} falling edge
t ₁₇	100/2000	ns min/max	\overline{LDAC} falling edge to DAC output response time
t ₁₈	8	μs typ	DAC output settling time
t ₁₉	20	ns min	\overline{CLR} pulse width low
t ₂₀	40	μs max	\overline{CLR} pulse activation time

¹ Guaranteed by design and characterization, not production tested.

² All input signals are specified with t_{tr} = t_r = 5 ns (10% to 90% of DVDD) and timed from a voltage level of 1.2 V.

³ See Figure 7.

⁴ See Figure 29.



¹ \overline{LDAC}^1 ACTIVE DURING \overline{BUSY} .
² \overline{LDAC}^2 ACTIVE AFTER \overline{BUSY} .

Figure 7. Parallel Interface Timing Diagram

08751-007

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted¹.

Table 7.

Parameter	Rating
AVDD to AGND	-0.3 V to +7 V
DVDD to DGND	-0.3 V to +7 V
Digital Inputs to DGND	-0.3 V to DVDD + 0.3 V
SDA/SCL to DGND	-0.3 V to +7 V
Digital Outputs to DGND	-0.3 V to DVDD + 0.3 V
REFIN/REFOUT to AGND	-0.3 V to AVDD + 0.3 V
AGND to DGND	-0.3 V to +0.3 V
VOU _{Tx} to AGND	-0.3 V to AVDD + 0.3 V
Analog Inputs to AGND	-0.3 V to AVDD + 0.3 V
Operating Temperature Range	
Commercial (B Version)	-40°C to +85°C
Storage Temperature Range	-65°C to +150°C
Junction Temperature ($T_{J\text{ MAX}}$)	150°C
100-Lead LQFP Package	
θ_{JA} Thermal Impedance	44°C/W
Reflow Soldering	
Peak Temperature	230°C
ESD	
HBM	6.5 kV
FICDM	2 kV

¹ Transient currents of up to 100 mA will not cause SCR latch-up.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

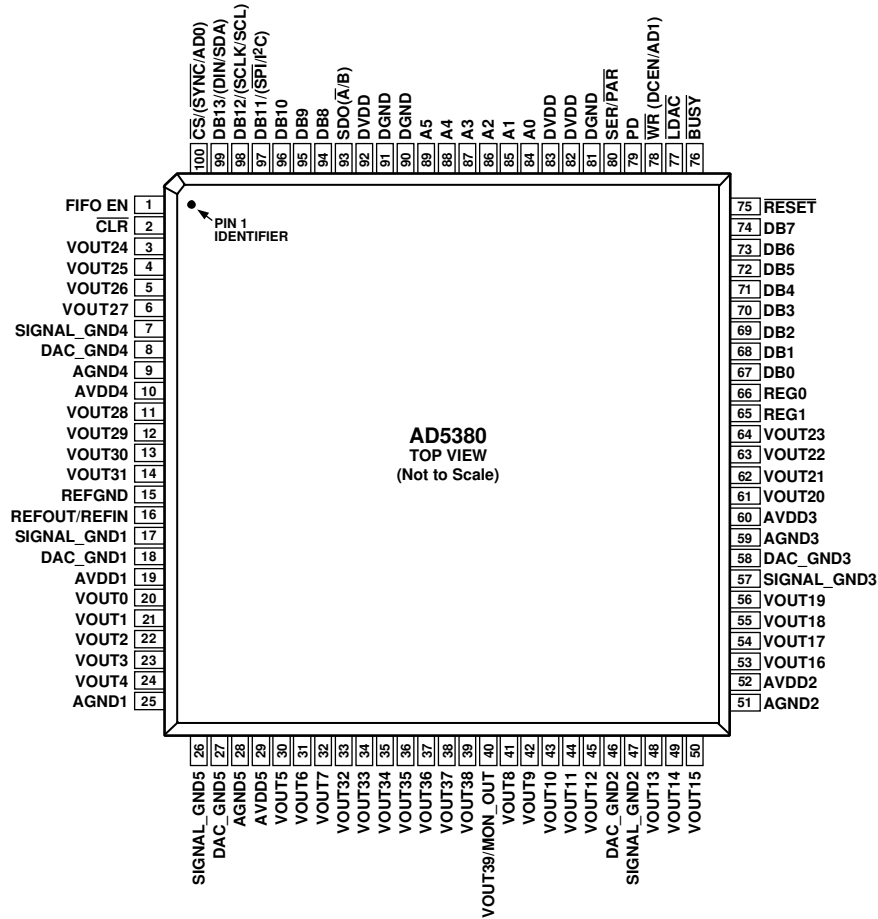


Figure 8. 100-Lead LQFP Pin Configuration

Table 8. Pin Function Descriptions

Mnemonic	Function
VOUTx	Buffered Analog Outputs for Channel x. Each analog output is driven by a rail-to-rail output amplifier operating at a gain of 2. Each output is capable of driving an output load of 5 kΩ to ground. Typical output impedance is 0.5 Ω.
SIGNAL_GND(1–5)	Analog Ground Reference Points for Each Group of Eight Output Channels. All SIGNAL_GND pins are tied together internally and should be connected to the AGND plane as close as possible to the AD5380.
DAC_GND(1–5)	Each group of eight channels contains a DAC_GND pin. This is the ground reference point for the internal 14-bit DAC. These pins should be connected to the AGND plane.
AGND(1–5)	Analog Ground Reference Point. Each group of eight channels contains an AGND pin. All AGND pins should be connected externally to the AGND plane.
AVDD(1–5)	Analog Supply Pins. Each group of eight channels has a separate AVDD pin. These pins are shorted internally and should be decoupled with a 0.1 μF ceramic capacitor and a 10 μF tantalum capacitor. Operating range for the AD5380-5 is 4.5 V to 5.5 V; operating range for the AD5380-3 is 2.7 V to 3.6 V.
DGND	Ground for All Digital Circuitry.
DVDD	Logic Power Supply. Guaranteed operating range is 2.7 V to 5.5 V. It is recommended that these pins be decoupled with 0.1 μF ceramic and 10 μF tantalum capacitors to DGND.
REFGND	Ground Reference Point for the Internal Reference.
REFOUT/REFIN	The AD5380 contains a common REFOUT/REFIN pin. When the internal reference is selected, this pin is the reference output. If the application requires an external reference, it can be applied to this pin and the internal reference can be disabled via the control register. The default for this pin is a reference input.

Mnemonic	Function
VOOUT39/MON_OUT	This pin has a dual function. It acts a buffered output for Channel 39 in default mode. However, when the monitor function is enabled, this pin acts as the output of a 39-to-1 channel multiplexer that can be programmed to multiplex one of Channels 0 to 38 to the MON_OUT pin. The MON_OUT pin's output impedance is typically 500 Ω and is intended to drive a high input impedance like that exhibited by SAR ADC inputs.
SER/ $\overline{\text{PAR}}$	Interface Select Input. This pin allows the user to select whether the serial or parallel interface will be used. If it is tied high, the serial interface mode is selected and Pin 97 ($\overline{\text{SPI}}/\text{I}^2\text{C}$) is used to determine if the interface mode is SPI or I^2C . Parallel interface mode is selected when SER/ $\overline{\text{PAR}}$ is low.
$\overline{\text{CS}}$ /($\overline{\text{SYNC}}$ /AD0)	In parallel interface mode, this pin acts as chip select input (level sensitive, active low). When low, the AD5380 is selected. Serial Interface Mode. This is the frame synchronization input signal for the serial clocks before the addressed register is updated. I^2C Mode. This pin acts as a hardware address pin used in conjunction with AD1 to determine the software address for the device on the I^2C bus.
$\overline{\text{WR}}$ /(DCEN/AD1)	Multifunction Pin. In parallel interface mode, this pin acts as write enable. In serial interface mode, this pin acts as a daisy-chain enable in SPI mode and as a hardware address pin in I^2C mode. Parallel Interface Write Input (Edge Sensitive). The rising edge of $\overline{\text{WR}}$ is used in conjunction with $\overline{\text{CS}}$ low and the address bus inputs to write to the selected device registers. Serial Interface. Daisy-chain select input (level sensitive, active high). When high, this signal is used in conjunction with SER/ $\overline{\text{PAR}}$ high to enable the $\overline{\text{SPI}}$ serial interface Daisy-Chain mode. I^2C Mode. This pin acts as a hardware address pin used in conjunction with AD0 to determine the software address for this device on the I^2C bus.
DB13–DB0	Parallel Data Bus. DB13 is the MSB and DB0 is the LSB of the input data-word on the AD5380.
A5–A0	Parallel Address Inputs. A5 to A0 are decoded to address one of the AD5380's 40 input channels. Used in conjunction with the REG1 and REG0 pins to determine the destination register for the input data.
REG1, REG0	In parallel interface mode, REG1 and REG0 are used in decoding the destination registers for the input data. REG1 and REG0 are decoded to address the input data register, offset register, or gain register for the selected channel and to decide the special function registers.
SDO/($\overline{\text{A}}$ /B)	Serial Data Output in Serial Interface Mode. Three-stateable CMOS output. SDO can be used for daisy-chaining a number of devices together. Data is clocked out on SDO on the rising edge of SCLK, and is valid on the falling edge of SCLK. When operating in parallel interface mode, this pin acts as the A or B data register select when writing data to the AD5380's data registers with toggle mode selected (see the Toggle Mode Function section). In toggle mode, the LDAC is used to switch the output between the data contained in the A and B data registers. All DAC channels contain two data registers. In normal mode, Data Register A is the default for data transfers.
$\overline{\text{BUSY}}$	Digital CMOS Output. $\overline{\text{BUSY}}$ goes low during internal calculations of the data (x2) loaded to the DAC data register. During this time, the user can continue writing new data to the x1, c, and m registers, but no further updates to the DAC registers and DAC outputs can take place. If $\overline{\text{LDAC}}$ is taken low while $\overline{\text{BUSY}}$ is low, this event is stored. $\overline{\text{BUSY}}$ also goes low during power-on reset, and when the $\overline{\text{BUSY}}$ pin is low. During this time, the interface is disabled and any events on $\overline{\text{LDAC}}$ are ignored. A $\overline{\text{CLR}}$ operation also brings $\overline{\text{BUSY}}$ low.
$\overline{\text{LDAC}}$	Load DAC Logic Input (Active Low). If $\overline{\text{LDAC}}$ is taken low while $\overline{\text{BUSY}}$ is inactive (high), the contents of the input registers are transferred to the DAC registers and the DAC outputs are updated. If $\overline{\text{LDAC}}$ is taken low while $\overline{\text{BUSY}}$ is active and internal calculations are taking place, the $\overline{\text{LDAC}}$ event is stored and the DAC registers are updated when $\overline{\text{BUSY}}$ goes inactive. However, any events on $\overline{\text{LDAC}}$ during power-on reset or on $\overline{\text{RESET}}$ are ignored.
$\overline{\text{CLR}}$	Asynchronous Clear Input. The $\overline{\text{CLR}}$ input is falling edge sensitive. When $\overline{\text{CLR}}$ is activated, all channels are updated with the data contained in the $\overline{\text{CLR}}$ code register. $\overline{\text{BUSY}}$ is low for a duration of 35 μs while all channels are being updated with the $\overline{\text{CLR}}$ code.
$\overline{\text{RESET}}$	Asynchronous Digital Reset Input (Falling Edge Sensitive). The function of this pin is equivalent to that of the power-on reset generator. When this pin is taken low, the state machine initiates a reset sequence to digitally reset the x1, m, c, and x2 registers to their default power-on values. This sequence typically takes 270 μs . The falling edge of $\overline{\text{RESET}}$ initiates the $\overline{\text{RESET}}$ process and $\overline{\text{BUSY}}$ goes low for the duration, returning high when $\overline{\text{RESET}}$ is complete. While $\overline{\text{BUSY}}$ is low, all interfaces are disabled and all $\overline{\text{LDAC}}$ pulses are ignored. When $\overline{\text{BUSY}}$ returns high, the part resumes normal operation, and the status of the $\overline{\text{RESET}}$ pin is ignored until the next falling edge is detected.
PD	Power Down (Level Sensitive, Active High). PD is used to place the device in low power mode, where AI_{DD} reduces to 2 μA and DI_{DD} to 20 μA . In power-down mode, all internal analog circuitry is placed in low power mode, and the analog output will be configured as a high impedance output or will provide a 100 k Ω load to ground, depending on how the power-down mode is configured. The serial interface remains active during power-down.

Mnemonic	Function
FIFO EN	FIFO Enable (Level Sensitive, Active High). When connected to DVDD, the internal FIFO is enabled, allowing the user to write to the device at full speed. FIFO is only available in parallel interface mode. The status of the FIFO EN pin is sampled on power-up, and also following a CLEAR or RESET, to determine if the FIFO is enabled. In either serial or I ² C interface modes, the FIFO EN pin should be tied low.
DB11/($\overline{\text{SPI}}$ /I ² C)	Multifunction Input Pin. In parallel interface mode, this pin acts as DB11 of the parallel input data-word. In serial interface mode, this pin acts as serial interface mode select. When serial interface mode is selected ($\text{SER}/\overline{\text{PAR}} = 1$) and this input is low, $\overline{\text{SPI}}$ mode is selected. In $\overline{\text{SPI}}$ mode, DB12 is the serial clock (SCLK) input and DB13 is the serial data (DIN) input. When serial interface mode is selected ($\text{SER}/\overline{\text{PAR}} = 1$) and this input is high, I ² C mode is selected. In this mode, DB12 is the serial clock (SCL) input, and DB13 is the serial data (SDA) input.
DB12/(SCLK/SCL)	Multifunction Input Pin. In parallel interface mode, this pin acts as DB12 of the parallel input data-word. In serial interface mode, this pin acts as a serial clock input. Serial Interface Mode. In serial interface mode, data is clocked into the shift register on the falling edge of SCLK. This operates at clock speeds up to 30 MHz. I ² C Mode. In I ² C mode, this pin performs the SCL function, clocking data into the device. The data transfer rate in I ² C mode is compatible with both 100 kHz and 400 kHz operating modes.
DB13/(DIN/SDA)	Multifunction Data Input Pin. In parallel interface mode, this pin acts as DB13 of the parallel input data-word. Serial Interface Mode. In serial interface mode, this pin acts as the serial data input. Data must be valid on the falling edge of SCLK. I ² C Mode. In I ² C mode, this pin is the serial data pin (SDA) operating as an open-drain input/output.

TERMINOLOGY

Relative Accuracy

Relative accuracy, or endpoint linearity, is a measure of the maximum deviation from a straight line passing through the endpoints of the DAC transfer function. It is measured after adjusting for zero-scale error and full-scale error, and is expressed in LSB.

Differential Nonlinearity

Differential nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of 1 LSB maximum ensures monotonicity.

Zero-Scale Error

Zero-scale error is the error in the DAC output voltage when all 0s are loaded into the DAC register. Ideally, with all 0s loaded to the DAC and $m = \text{all } 1\text{s}$, $c = 2^n - 1$

$$VOUT_{(Zero-Scale)} = 0 \text{ V}$$

Zero-scale error is a measure of the difference between $VOUT$ (actual) and $VOUT$ (ideal), expressed in mV. It is mainly due to offsets in the output amplifier.

Offset Error

Offset error is a measure of the difference between $VOUT$ (actual) and $VOUT$ (ideal) in the linear region of the transfer function, expressed in mV. Offset error is measured on the [AD5380-5](#) with Code 32 loaded into the DAC register, and on the [AD5380-3](#) with Code 64.

Gain Error

Gain Error is specified in the linear region of the output range between $VOUT = 10 \text{ mV}$ and $VOUT = AVDD - 50 \text{ mV}$. It is the deviation in slope of the DAC transfer characteristic from the ideal and is expressed in %FSR with the DAC output unloaded.

DC Crosstalk

This is the dc change in the output level of one DAC at midscale in response to a full-scale code (all 0s to all 1s, and vice versa) and output change of all other DACs. It is expressed in LSB.

DC Output Impedance

This is the effective output source resistance. It is dominated by package lead resistance.

Voltage Settling Time

This is the amount of time it takes for the output of a DAC to settle to a specified level for a $\frac{1}{4}$ to $\frac{3}{4}$ full-scale input change, and is measured from the \overline{BUSY} rising edge.

Digital-to-Analog Glitch Energy

This is the amount of energy injected into the analog output at the major code transition. It is specified as the area of the glitch in nV-s. It is measured by toggling the DAC register data between 0x1FFF and 0x2000.

DAC-to-DAC Crosstalk

DAC-to-DAC crosstalk is the glitch impulse that appears at the output of one DAC due to both the digital change and the subsequent analog output change at another DAC. The victim channel is loaded with midscale. DAC-to-DAC crosstalk is specified in nV-s.

Digital Crosstalk

The glitch impulse transferred to the output of one converter due to a change in the DAC register code of another converter is defined as the digital crosstalk and is specified in nV-s.

Digital Feedthrough

When the device is not selected, high frequency logic activity on the device's digital inputs can be capacitively coupled both across and through the device to show up as noise on the $VOUT$ pins. It can also be coupled along the supply and ground lines. This noise is digital feedthrough.

Output Noise Spectral Density

This is a measure of internally generated random noise. Random noise is characterized as a spectral density (voltage per $\sqrt{\text{Hertz}}$). It is measured by loading all DACs to midscale and measuring noise at the output. It is measured in $nV/\sqrt{\text{Hz}}$ in a 1 Hz bandwidth at 10 kHz.

TYPICAL PERFORMANCE CHARACTERISTICS

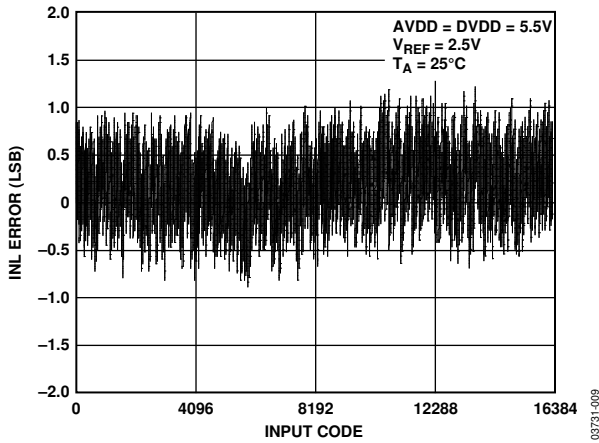


Figure 9. Typical AD5380-5 INL Plot

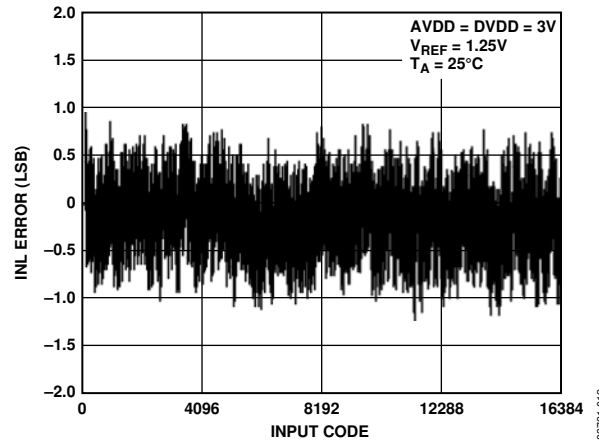


Figure 12. Typical AD5380-3 INL Plot

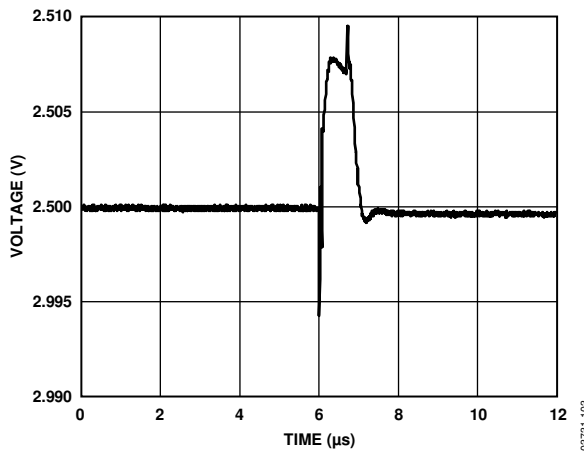


Figure 10. AD5380-5 Glitch Impulse

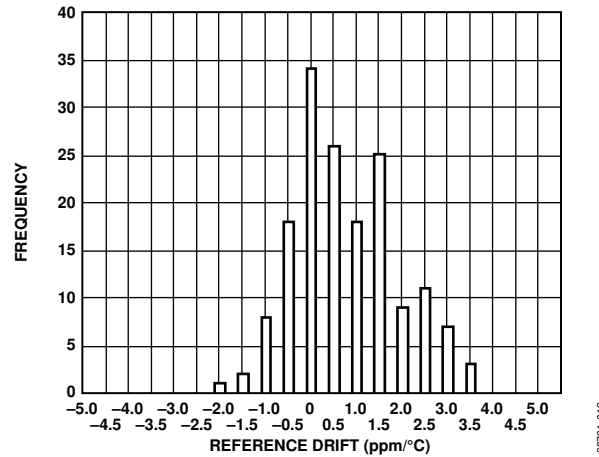


Figure 13. REFOUT Temperature Coefficient

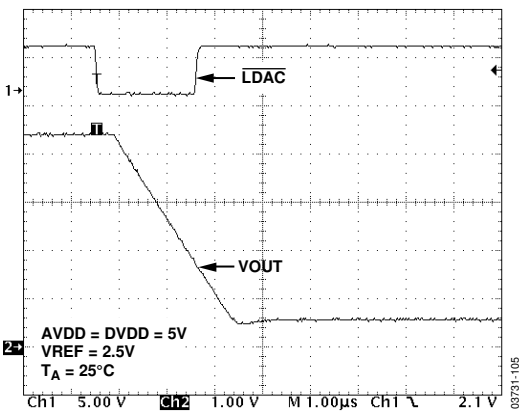


Figure 11. Slew Rate with Boost Off

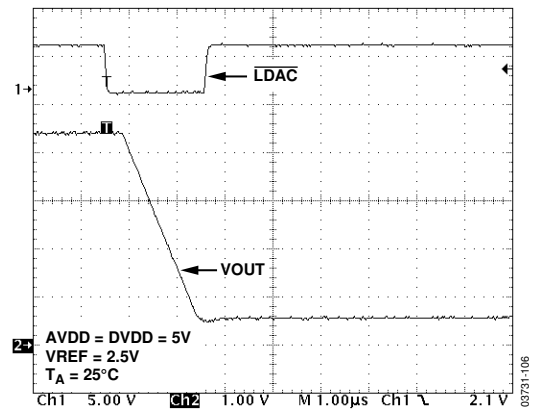


Figure 14. Slew Rate with Boost On

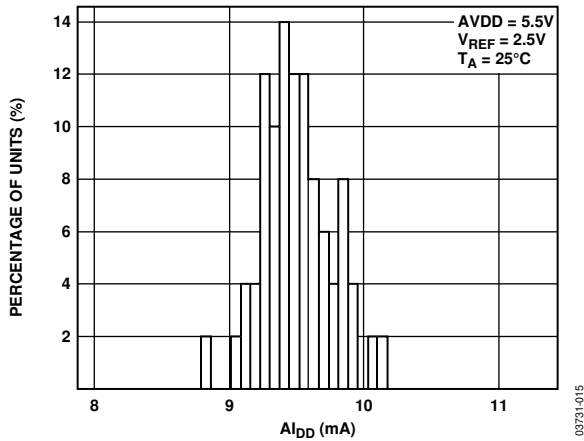


Figure 15. $A_{I_{DD}}$ Histogram with Boost Off

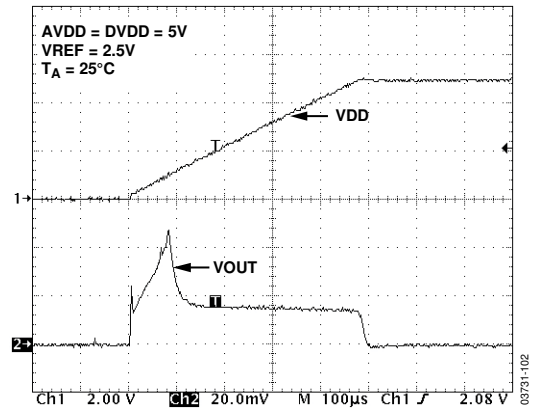


Figure 18. AD5380 Power-Up Transient

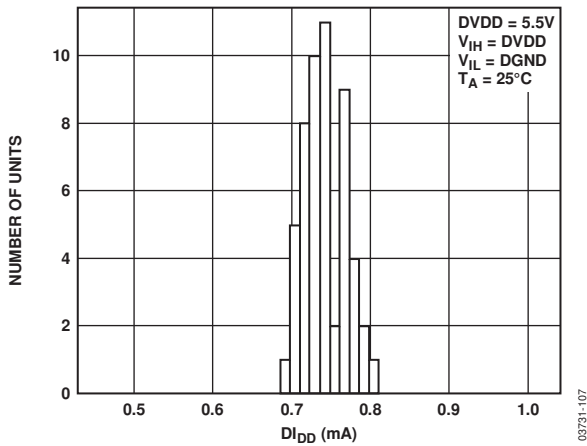


Figure 16. $D_{I_{DD}}$ Histogram

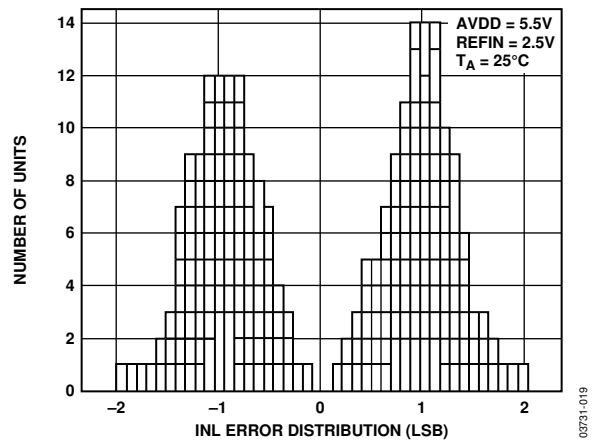


Figure 19. INL Distribution

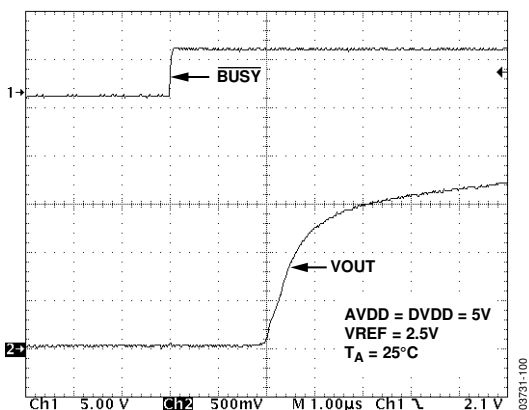


Figure 17. Exiting Soft Power Down

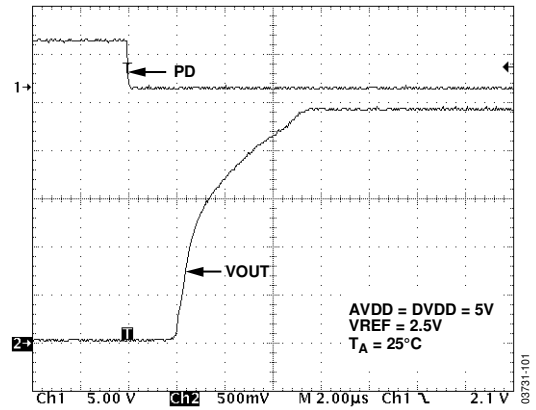


Figure 20. Exiting Hardware Power Down

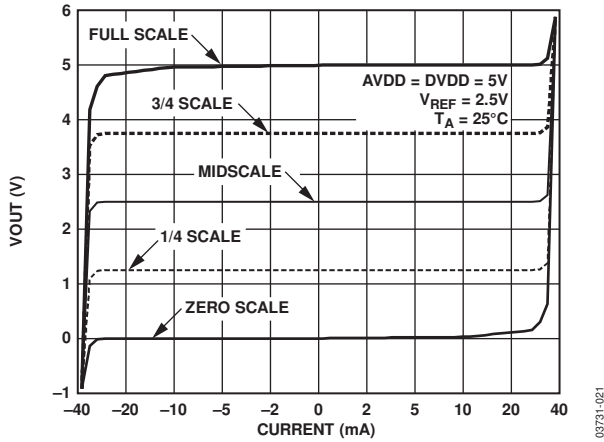


Figure 21. AD5380-5 Output Amplifier Source and Sink Capability

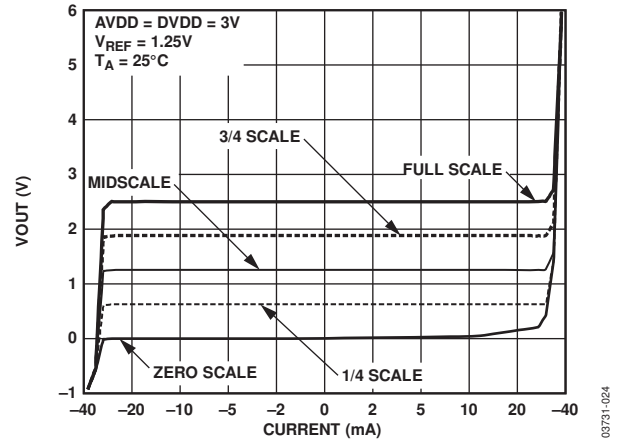


Figure 24. AD5380-3 Output Amplifier Source and Sink Capability

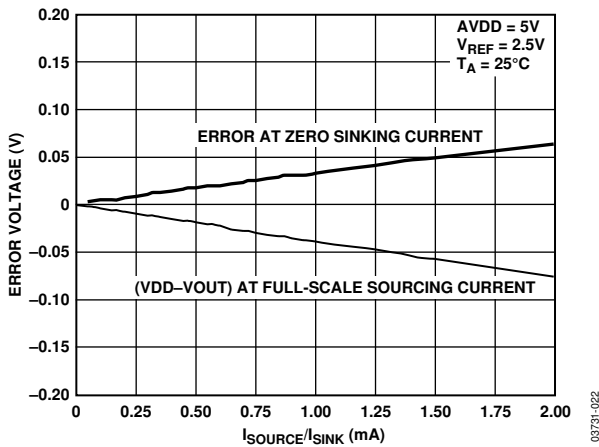


Figure 22. Headroom at Rails vs. Source/Sink Current

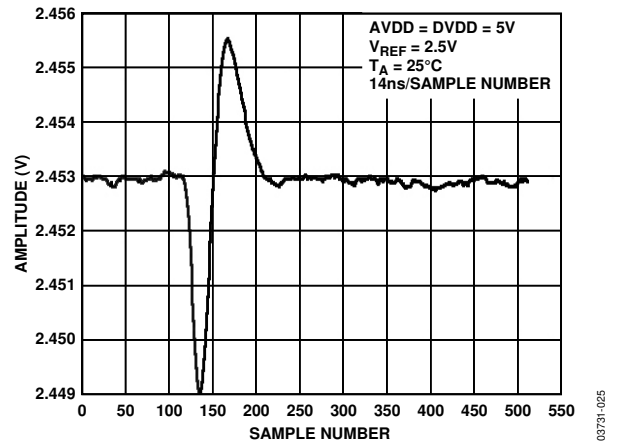


Figure 25. Adjacent Channel DAC-to-DAC Crosstalk

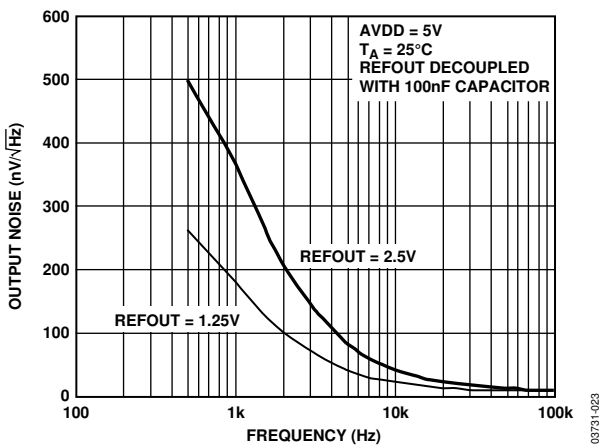


Figure 23. REFOUT Noise Spectral Density

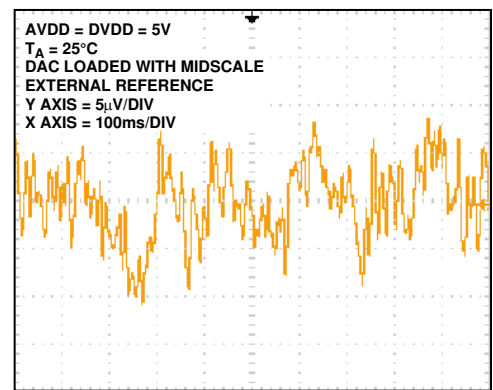


Figure 26. 0.1 Hz to 10 Hz Noise Plot

FUNCTIONAL DESCRIPTION

DAC ARCHITECTURE—GENERAL

The **AD5380** is a complete, single-supply, 40-channel voltage output DAC that offers 14-bit resolution. The part is available in a 100-lead LQFP package and features both a parallel and a serial interface. This product includes an internal, software selectable, 1.25 V/2.5 V, 10 ppm/°C reference that can be used to drive the buffered reference inputs; alternatively, an external reference can be used to drive these inputs. Internal/external reference selection is via the CR10 bit in the control register; CR12 selects the reference magnitude if the internal reference is rail-to-rail output capable of driving 5 kΩ in parallel with a 200 pF load.

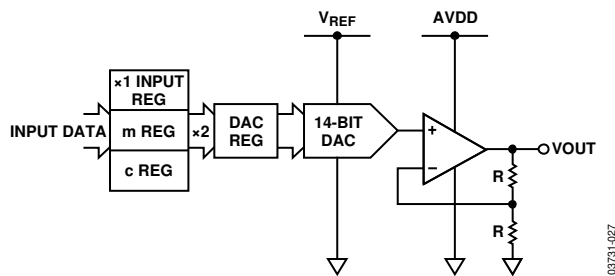


Figure 27. Single-Channel Architecture

The architecture of a single DAC channel consists of a 14-bit resistor-string DAC followed by an output buffer amplifier operating at a gain of 2. This resistor-string architecture guarantees DAC monotonicity. The 14-bit binary digital code loaded to the DAC register determines at what node on the string the voltage is tapped off before being fed to the output amplifier. Each channel on these devices contains independent offset and gain control registers that allow the user to digitally trim offset and gain. These registers give the user the ability to calibrate out errors in the complete signal chain, including the DAC, using the internal *m* and *c* registers, which hold the correction factors.

All channels are double buffered, allowing synchronous updating of all channels using the LDAC pin. Figure 27 shows a block diagram of a single channel on the **AD5380**. The digital input transfer function for each DAC can be represented as

$$x2 = [(m + 2)/2^n \times x1] + (c - 2^{n-1})$$

where:

x2 is the data-word loaded to the resistor string DAC.

x1 is the 14-bit data-word written to the DAC input register.

m is the gain coefficient (default is 0x3FFE on the **AD5380**).

The gain coefficient is written to the 13 most significant bits (DB13 to DB1) and the LSB (DB0) is zero.

n = DAC resolution (*n* = 14 for **AD5380**).

c is the 14-bit offset coefficient (default is 0x2000).

The complete transfer function for these devices can be represented as

$$VOUT = 2 \times VREF \times x2/2^n$$

x2 is the data-word loaded to the resistor string DAC. *VREF* is the internal reference voltage or the reference voltage externally applied to the DAC REFOUT/REFIN pin. For specified performance, an external reference voltage of 2.5 V is recommended for the **AD5380-5**, and 1.25 V for the **AD5380-3**.

DATA DECODING

The **AD5380** contains a 14-bit data bus, DB13 to DB0. Depending on the value of REG1 and REG0 (see Table 1), this data is loaded into the addressed DAC input registers, offset (*c*) registers, or gain (*m*) registers. The format data, offset (*c*), and gain (*m*) register contents are shown in Table 10 to Table 12.

Table 9. Register Selection

REG1	REG0	Register Selected
1	1	Input Data Register (<i>x1</i>)
1	0	Offset Register (<i>c</i>)
0	1	Gain Register (<i>m</i>)
0	0	Special Function Registers (SFRs)

Table 10. DAC Data Format (REG1 = 1, REG0 = 1)

DB13 to DB0				DAC Output (V)
11	1111	1111	1111	$2V_{REF} \times (16383/16384)$
11	1111	1111	1110	$2V_{REF} \times (16382/16384)$
10	0000	0000	0001	$2V_{REF} \times (8193/16384)$
10	0000	0000	0000	$2V_{REF} \times (8192/16384)$
01	1111	1111	1111	$2V_{REF} \times (8191/16384)$
00	0000	0000	0001	$2V_{REF} \times (1/16384)$
00	0000	0000	0000	0

Table 11. Offset Data Format (REG1 = 1, REG0 = 0)

DB13 to DB0				Offset (LSB)
11	1111	1111	1111	+8191
11	1111	1111	1110	+8190
10	0000	0000	0001	+1
10	0000	0000	0000	0
01	1111	1111	1111	-1
00	0000	0000	0001	-8191
00	0000	0000	0000	-8192

Table 12. Gain Data Format (REG1 = 0, REG0 = 1)

DB13 to DB0				Gain Factor
11	1111	1111	1110	1
10	1111	1111	1110	0.75
01	1111	1111	1110	0.5
00	1111	1111	1110	0.25
00	0000	0000	0000	0

ON-CHIP SPECIAL FUNCTION REGISTERS (SFR)

The AD5380 contains a number of special function registers (SFRs), as outlined in Table 13. SFRs are addressed with $REG1 = REG0 = 0$ and are decoded using Address Bits A5 to A0.

Table 13. SFR Register Functions ($REG1 = 0$, $REG0 = 0$)

R/W	A5	A4	A3	A2	A1	A0	Function
X	0	0	0	0	0	0	NOP (No Operation)
0	0	0	0	0	0	1	Write CLR Code
0	0	0	0	0	1	0	Soft CLR
0	0	0	1	0	0	0	Soft Power-Down
0	0	0	1	0	0	1	Soft Power-Up
0	0	0	1	1	0	0	Control Register Write
1	0	0	1	1	0	0	Control Register Read
0	0	0	1	0	1	0	Channel Monitor
0	0	0	1	1	1	1	Soft Reset

SFR COMMANDS

NOP (No Operation)

$REG1 = REG0 = 0$, A5 to A0 = 000000

Performs no operation, but is useful in serial readback mode to clock out data on D_{OUT} for diagnostic purposes. $BUSY$ pulses low during a NOP operation.

Write CLR Code

$REG1 = REG0 = 0$, A5–A0 = 000001

DB13 to DB0 = Contain the CLR data

Bringing the \overline{CLR} line low or exercising the soft clear function will load the contents of the DAC registers with the data contained in the user configurable \overline{CLR} register, and will set $VOUT0$ to $VOUT39$ accordingly. This can be very useful for setting up a specific output voltage in a clear condition. It is also beneficial for calibration purposes; the user can load full scale or zero scale to the clear code register and then issue a hardware or software clear to load this code to all DACs, removing the need for individual writes to each DAC. Default on power-up is all zeros.

Soft CLR

$REG1 = REG0 = 0$, A5 to A0 = 000010

DB13 to DB0 = Don't Care

Executing this instruction performs the CLR, which is functionally the same as that provided by the external \overline{CLR} pin.

The DAC outputs are loaded with the data in the CLR code register. It takes $35 \mu s$ to fully execute the SOFT CLR, as indicated by the $BUSY$ low time.

Soft Power-Down

$REG1 = REG0 = 0$, A5 to A0 = 001000

DB13 to DB0 = Don't Care

Executing this instruction performs a global power-down feature that puts all channels into a low power mode that reduces the analog supply current to $2 \mu A$ max and the digital current to $20 \mu A$ max. In power-down mode, the output amplifier can be configured as a high impedance output or can provide a $100 k\Omega$ load to ground. The contents of all internal registers are retained in power-down mode. No register can be written to while in power-down.

Soft Power-Up

$REG1 = REG0 = 0$, A5 to A0 = 001001

DB13 to DB0 = Don't Care

This instruction is used to power up the output amplifiers and the internal reference. The time to exit power-down is $8 \mu s$. The hardware power-down and software function are internally combined in a digital OR function.

Soft RESET

$REG1 = REG0 = 0$, A5 to A0 = 001111

DB13 to DB0 = Don't Care

This instruction is used to implement a software reset. All internal registers are reset to their default values, which correspond to m at full scale and c at zero scale. The contents of the DAC registers are cleared, setting all analog outputs to 0 V. The soft reset activation time is $135 \mu s$. Only perform a soft reset when the AD5380 is not in power-down mode.

Table 14. Control Register Contents

MSB												LSB	
CR13	CR12	CR11	CR10	CR9	CR8	CR7	CR6	CR5	CR4	CR3	CR2	CR1	CR0

Control Register Write/Read

REG1 = REG0 = 0, A5 to A0 = 001100, R/\overline{W} status determines if the operation is a write ($R/\overline{W} = 0$) or a read ($R/\overline{W} = 1$). DB13 to DB0 contains the control register data.

Control Register Contents

CR13: Power-Down Status. This bit is used to configure the output amplifier state in power down.

CR13 = 1. Amplifier output is high impedance (default on power-up).

CR13 = 0. Amplifier output is 100 k Ω to ground.

CR12: REF Select. This bit selects the operating internal reference for the AD5380. CR12 is programmed as follows:

CR12 = 1: Internal reference is 2.5 V (AD5380-5 default), the recommended operating reference for AD5380-5.

CR12 = 0: Internal reference is 1.25 V (AD5380-3 default), the recommended operating reference for AD5380-3.

CR11: Current Boost Control. This bit is used to boost the current in the output amplifier, thereby altering its slew rate. This bit is configured as follows:

CR11 = 1: Boost Mode On. This maximizes the bias current in the output amplifier, optimizing its slew rate but increasing the power dissipation.

CR11 = 0: Boost Mode Off (default on power-up). This reduces the bias current in the output amplifier and reduces the overall power consumption.

CR10: Internal/External Reference. This bit determines if the DAC uses its internal reference or an externally applied reference.

CR10 = 1: Internal Reference Enabled. The reference output depends on data loaded to CR12.

CR10 = 0: External Reference Selected (default on power-up).

CR9: Channel Monitor Enable (see Channel Monitor Function).

CR9 = 1: Monitor Enabled. This enables the channel monitor function. After a write to the monitor channel in the SFR register, the selected channel output is routed to the MON_OUT pin. VOUT39 operates as the MON_OUT pin.

CR9 = 0: Monitor Disabled (default on power-up). When the monitor is disabled, the MON_OUT pin assumes its normal DAC output function.

CR8: Thermal Monitor Function. This function is used to monitor the AD5380's internal die temperature when enabled. The thermal monitor powers down the output amplifiers when the temperature exceeds 130°C. This function can be used to protect the device in cases where power dissipation may be exceeded if a number of output channels are simultaneously short-circuited. A soft power-up will re-enable the output amplifiers if the die temperature has dropped below 130°C.

CR8 = 1: Thermal Monitor Enabled.

CR8 = 0: Thermal Monitor Disabled (default on power-up).

CR7: Don't Care.

CR6 to CR2: Toggle Function Enable. This function allows the user to toggle the output between two codes loaded to the A and B registers for each DAC. Control Register Bits CR6 to CR2 are used to enable individual groups of eight channels for operation in toggle mode. A Logic 1 written to any bit enables a group of channels; a Logic 0 disables a group. LDAC is used to toggle between the two registers. Table 15 shows the decoding for toggle mode operation. For example, CR6 controls Group w, which contains Channel 32 to Channel 39, CR6 = 1 enables these channels.

CR1 and CR0: Don't Care.

Table 15.

CR Bit	Group	Channels
CR6	4	32–39
CR5	3	24–31
CR4	2	16–23
CR3	1	8–15
CR2	0	0–7

Channel Monitor Function

REG1 = REG0 = 0, A5 to A0 = 001010

DB13 to DB8 = Contain data to address the monitored channel.

A channel monitor function is provided on the AD5380. This feature, which consists of a multiplexer addressed via the interface, allows any channel output to be routed to the MON_OUT pin for monitoring using an external ADC. In channel monitor mode, VOUT39 becomes the MON_OUT pin, to which all monitored pins are routed. The channel monitor function must be enabled in the control register before any channels are routed to MON_OUT. On the AD5380, DB13 to DB8 contain the channel address for the monitored channel. Selecting Channel Address 63 three-states MON_OUT.